

IRFB3004PBF-VB Datasheet

N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	40				
$R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$	0.00084				
I _D (A)	409				
Configuration	Single				
Qg (nC)	250				

FEATURES

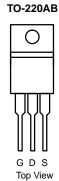
- Trench Power MOSFET
- 100 % R_g and UIS Tested

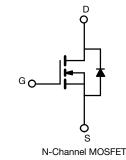
APPLICATIONS

- Synchronous Rectification
- Power Supplies



COMPLIANT HALOGEN





PARAMETER Drain-source voltage Gate-source voltage		SYMBOL	LIMIT	- V
		V _{DS} V _{GS}	40	
			± 20	
Continuous drain current ^a	T _C = 25 °C	- I _D	409	
	T _C = 125 °C		320	
Continuous source current (diode conduction) ^a		I _S	409	А
Pulsed drain current ^b		I _{DM}	600	
Single pulse avalanche current	L = 0.1 mH	I _{AS}	100	
Single pulse avalanche energy		E _{AS}	500	mJ
Maximum power dissipation ^b	T _C = 25 °C	Pn	375	w
	T _C = 125 °C	ГD	125	vv
Operating junction and storage temperature	range	T _J , T _{stg}	-55 to +175	°C

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-ambient	PCB mount ^c	R _{thJA}	40	°C/W		
Junction-to-case (drain)		R _{thJC}	0.4	0/10		

Notes

a. Based on T = 25 °C.

b. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

c. When mounted on 1" square PCB (FR4 material)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		•			<u> </u>		1	
Drain-source breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	40	-	-	v	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		2.5	3.0	3.5	v	
Gate-source leakage	I _{GSS}	V _{DS} =	0 V, $V_{GS} = \pm 20$ V	-	-	± 100	nA	
		V _{GS} = 0 V V _{DS} = 40 V		-	-	1		
Zero gate voltage drain current	I _{DSS}	$V_{GS} = 0 V$	$V_{DS} = 40 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	50	μA	
		$V_{GS} = 0 V$	V _{DS} = 40 V, T _J = 175 °C	-	-	300	μA	
On-state drain current ^a	I _{D(on)}	V _{GS} = 10 V	$V_{DS} \ge 5 V$	100	-	-	Α	
		$V_{GS} = 10 V$	I _D = 35 A	-	0.00084	-	1	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 35 A, T _J = 125 °C	-	0.00140	-	Ω	
		V _{GS} = 10 V	I _D = 35 A, T _J = 175 °C	-	0.00164	-		
Forward transconductance b	9 _{fs}	V _{DS}	= 15 V, I _D = 30 A	-	196	-	S	
Dynamic ^b		•					•	
Input capacitance	C _{iss}			-	11 938	15 525		
Output capacitance	C _{oss}	$V_{GS} = 0 V$	$V_{DS} = 25 V$, f = 1 MHz	-	11 163	14 520	pF	
Reverse transfer capacitance	C _{rss}			-	282	370		
Total gate charge ^c	Qg			-	158	250		
Gate-source charge ^c	Q _{gs}	$V_{GS} = 10 V$	$V_{DS} = 20 \text{ V}, I_{D} = 100 \text{ A}$	-	44	-	nC	
Gate-drain charge ^c	Q _{gd}			-	22	-		
Gate resistance	R _g		f = 1 MHz	2.70	5.44	8.20	Ω	
Turn-on delay time ^c	t _{d(on)}			-	16	25		
Rise time ^c	t _r	$\label{eq:VDD} \begin{array}{l} V_{DD} = 20 \ V, \ R_{L} = 0.2 \ \Omega \\ I_{D} \cong 100 \ A, \ V_{GEN} = 10 \ V, \ R_{g} = 1 \ \Omega \end{array}$		-	10	17	- ns	
Turn-off delay time ^c	t _{d(off)}			-	103	160		
Fall time ^c	t _f			-	61	95	1	
Source-Drain Diode Ratings and Chara	cteristics ^b							
Pulsed current ^a	I _{SM}			-	-	260	Α	
Forward voltage	V _{SD}	I _F =	60 A, V _{GS} = 0 V	-	0.81	1.5	V	
Body diode reverse recovery time	t _{rr}			-	165	350	ns	
Body diode reverse recovery charge	Q _{rr}		A di/dt 100 A /us	-	530	1100	nC	
Reverse recovery fall time	t _a	$I_F = 30$	A, di/dt = 100 A/µs	-	66	-		
Reverse recovery rise time	t _b]		-	99	-	ns	
Body diode peak reverse recovery current	I _{RM(REC)}			-	-6.2	-	Α	

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

b. Guaranteed by design, not subject to production testing

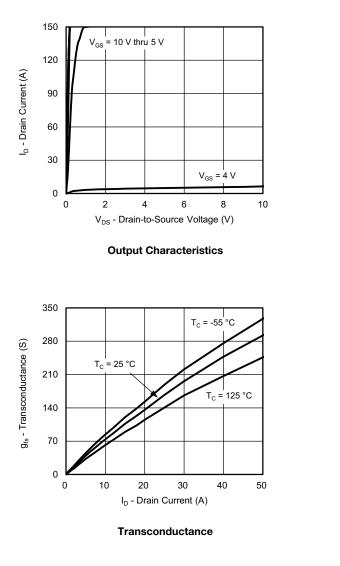
c. Independent of operating temperature

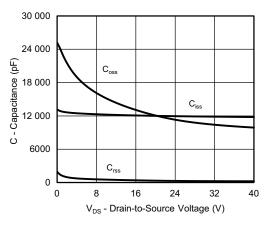
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi

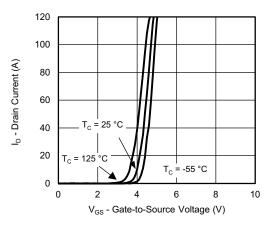


TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)

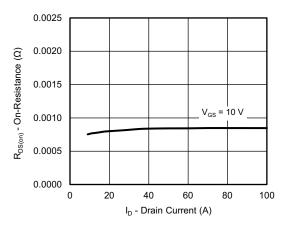




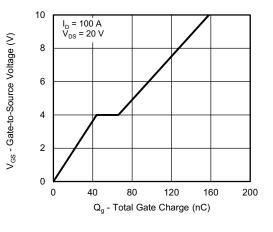
Capacitance



Transfer Characteristics



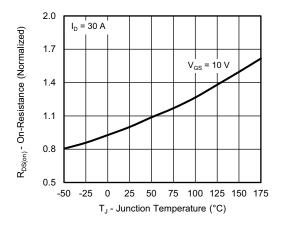
On-Resistance vs. Drain Current



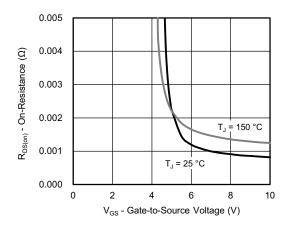
Gate Charge



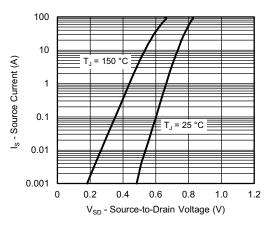
TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)



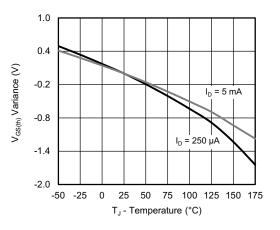
On-Resistance vs. Junction Temperature

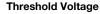


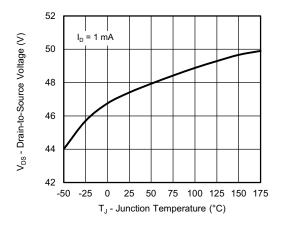
On-Resistance vs. Gate-to-Source Voltage



Source Drain Diode Forward Voltage



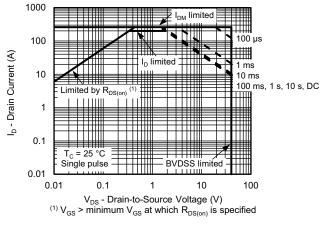




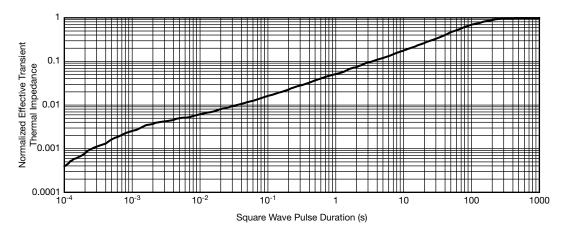
Drain Source Breakdown vs. Junction Temperature



THERMAL RATINGS ($T_A = 25 \ ^{\circ}C$, unless otherwise noted)



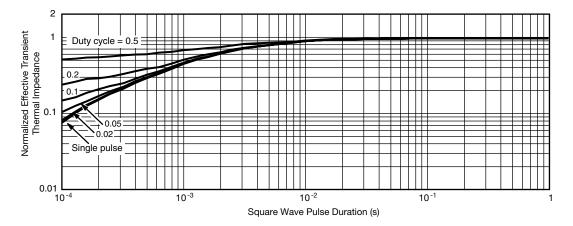
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

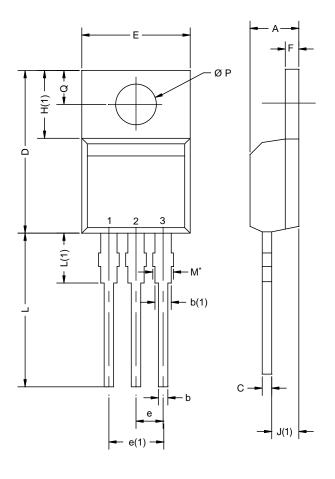
Note

- The characteristics shown in the two graphs
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions



TO-220AB



MIN. 4.25 0.69 1.20 0.36 14.85 10.04	MAX. 4.65 1.01 1.73 0.61 15.49	MIN. 0.167 0.027 0.047 0.014 0.585	MAX. 0.183 0.040 0.068 0.024 0.610
0.69 1.20 0.36 14.85	1.01 1.73 0.61	0.027 0.047 0.014	0.040 0.068 0.024
1.20 0.36 14.85	1.73 0.61	0.047 0.014	0.068
0.36 14.85	0.61	0.014	0.024
14.85			
	15.49	0.585	0.610
10.04			0.010
	10.51	0.395	0.414
2.41	2.67	0.095	0.105
4.88	5.28	0.192	0.208
1.14	1.40	0.045	0.055
6.09	6.48	0.240	0.255
2.41	2.92	0.095	0.115
13.35	14.02	0.526	0.552
3.32	3.82	0.131	0.150
3.54	3.94	0.139	0.155
2.60	3.00	0.102	0.118
	4.88 1.14 6.09 2.41 13.35 3.32 3.54 2.60	4.88 5.28 1.14 1.40 6.09 6.48 2.41 2.92 13.35 14.02 3.32 3.82 3.54 3.94	4.88 5.28 0.192 1.14 1.40 0.045 6.09 6.48 0.240 2.41 2.92 0.095 13.35 14.02 0.526 3.32 3.82 0.131 3.54 3.94 0.139 2.60 3.00 0.102

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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